## Notice of References Cited Application/Control No. 10/790,955 Examiner Jean M. Corrielus Applicant(s)/Patent Under Reexamination SCANLAN, LIAM Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,517,555	05-1996	Amadon et al.	455/408
*	В	US-5,729,735	03-1998	Meyering, Samuel C.	707/10
*	C	US-5,754,782	05-1998	Masada, Debra Nakanishi	709/213
*	D	US-5,758,359	05-1998	Saxon, Paul David	707/204
*	Е	US-5,796,999	08-1998	Azagury et al.	707/10
*	F	US-5,813,017	09-1998	Morris, Robert J. T.	707/204
*	G	US-5,857,208	01-1999	Ofek, Yuval	707/204
*	Ι	US-5,890,165	03-1999	Boudrie et al.	707/202
*	I	US-5,958,012	09-1999	Battat et al.	709/224
*	J	US-6,006,227	12-1999	Freeman et al.	707/7
*	K	US-6,035,412	03-2000	Tamer et al.	714/6
*		US-6,038,569	03-2000	Beavin et al.	707/203
*	М	US-6,289,380	09-2001	Battat et al.	709/224

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.